

**Search Notes**

Application/Control No.

10/760,614

Examiner

Linh V. Nguyen

Applicant(s)/Patent under  
Reexamination

RANDAHL ET AL.

Art Unit

2819

**SEARCHED**

Class	Subclass	Date	Examiner
330	10,51 251,270	5/1/2006	LN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East searched, see printout	5/1/2006	LN